Applicant(s)/Patent Under Application/Control No. Reexamination 10/662,040 BENDALE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Ha T. Nguyen 2812 **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Ε US-F US-G US-Н ı US-US-US-US-US-**FOREIGN PATENT DOCUMENTS** Date Document Number Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) Webster's II New College Dictionary, Houghton Mifflin Company, Boston. New York, 1995, page 214. ٧ W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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